

Please find the Video Tutorial at
<https://nanohub.org/resources/22447>

PhotonicVASEfit extracting optical constants of new materials by ellipsometry

FAQ

INTRO

TUTORIAL

DEMO

USING RESULTS

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nanoHUB FAQ

How do I ... ?

FAQ: How do I ... ?

How do I launch simulation tools?

All you need is to open an account - it's free!

Go to tool page and press 'Launch Tool' button

<https://nanohub.org/tools/photonicvasefit>

PhotonicVASEfit: VASE fitting tool

By Ludmila Prokopeva¹, You-Chia Chang², Alexander V. Kildishev (editor)³

1. Novosibirsk State University 2. University of Michigan 3. Purdue University

Retrieves optical constants of a material by fitting it to VASE (Variable Angle Spectroscopic Ellipsometry) data

Launch Tool

Version 1.3.1 - published on 11 Jun 2015

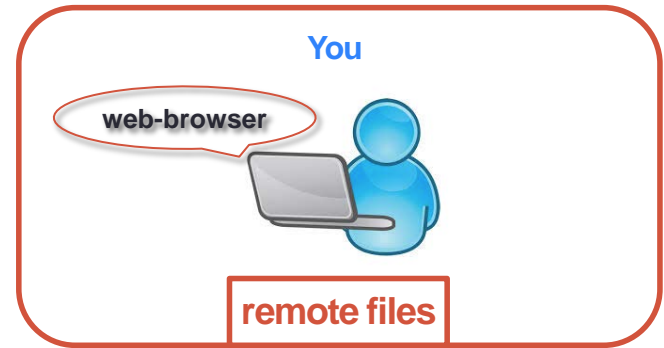
doi:10.4231/D39Z90C98 cite this

This tool is closed source.

View All Supporting Documents

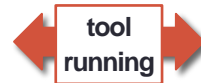
How do I upload (ellipsometry data) file to use it with the tool?

Understand file systems locations and directories



% simulation tool directory, auto cleaned
/home/nanohub/userName/data/sessions/852606

(examples)



% your home directory ("Storage"), fixed
/home/nanohub/userName



Upload

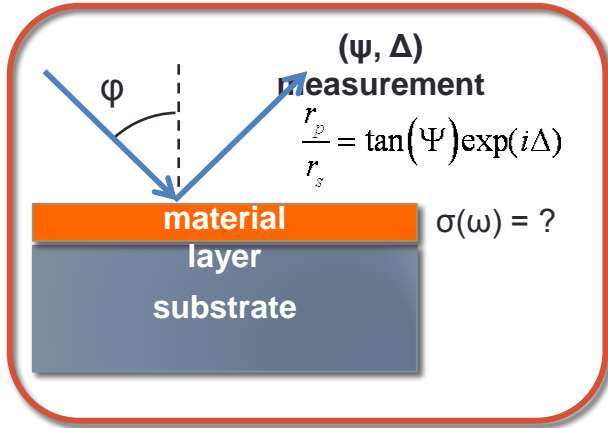
Use this form to upload data. If you don't specify a file for a particular input, that input won't be modified by the Upload operation.

% webdav (native support for most OS)
<https://webdav.nanohub.org/webdav>

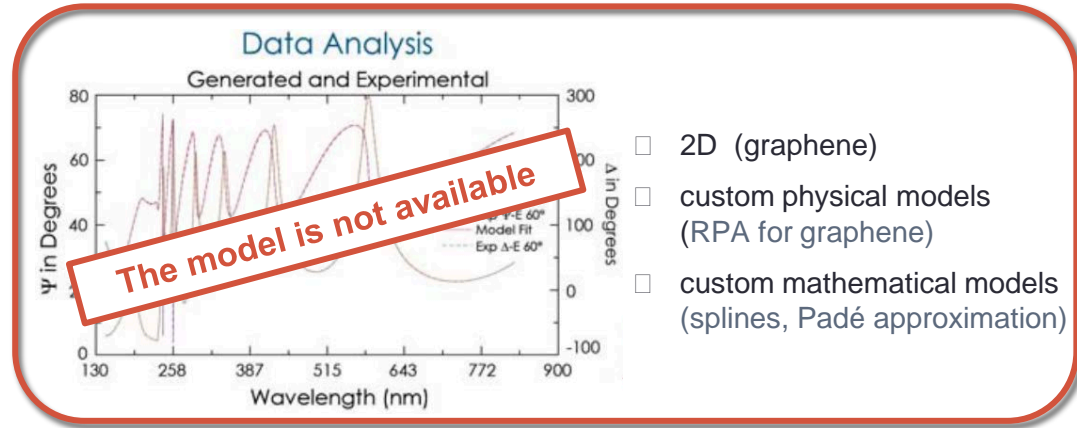
% ssh, scp (natively or client, e.g. WinSCP)
nanohub.org (nanoHUB username & password)

INTRODUCTION

INTRO: WHY ANOTHER TOOL?



Variable Angle Spectroscopic Ellipsometer



Sounds familiar?

Try **PhotonicVASEfit**

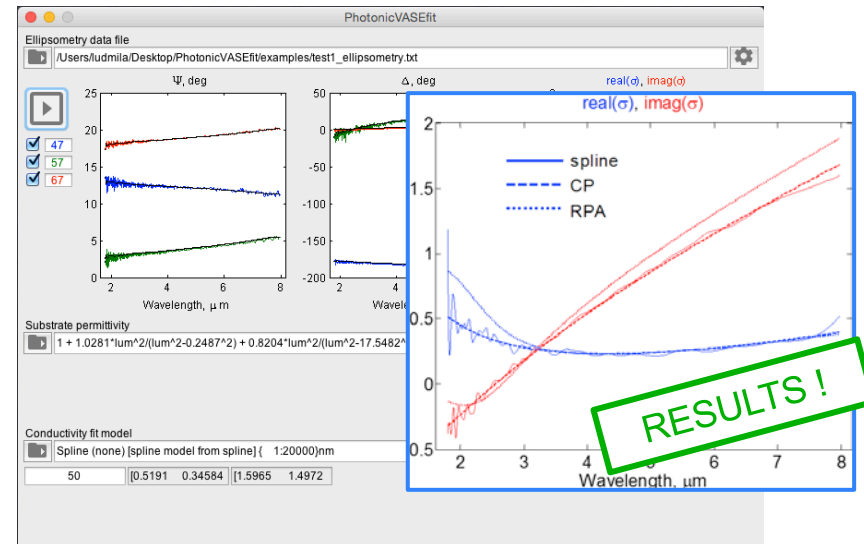
A light fitting companion for ellipsometry measurements

- 2D
- custom physical models
- custom mathematical models

new materials

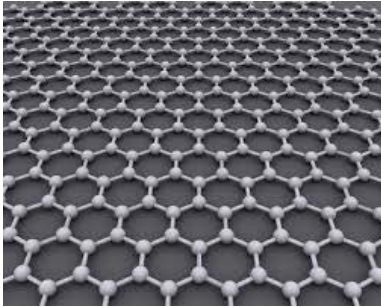


Powered by



- Current functionality is limited to a 2D-layer on a substrate. More is under development: we've just started!

INTRO: GRAPHENE MODELS



Graphene, a new optical material

- 2D material (atomic thickness)
- plasmonics
- tunable optical response, controlled by applied bias voltage

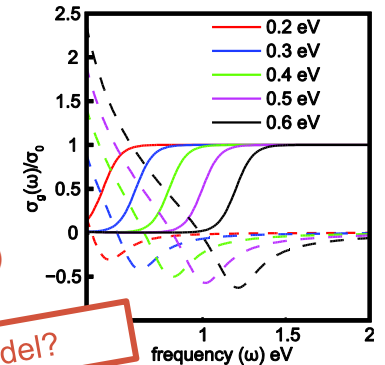
Low & Avouris, ACS Nano, 2014, 8 (2), 1086–1101

Fundamental model for relative surface conductivity ($\sigma_r = \sigma/\sigma_0$) of graphene

$$\sigma_{\text{RPA}}(\omega) = \frac{8\nu}{\pi} \frac{\omega_T}{\omega + i\Gamma} \log \left[2 \cosh \left(\frac{\omega_F}{2\omega_T} \right) \right] + \frac{4}{\nu\pi} (\omega + i\gamma) \int_0^\infty \frac{f(\omega')}{4\omega'^2 - (\omega + i\gamma)^2} d\omega'$$

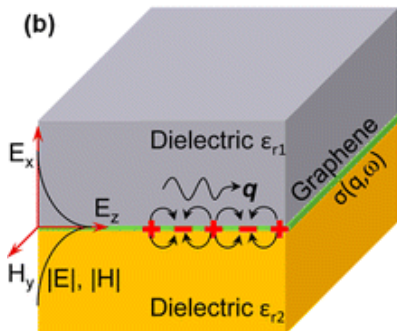
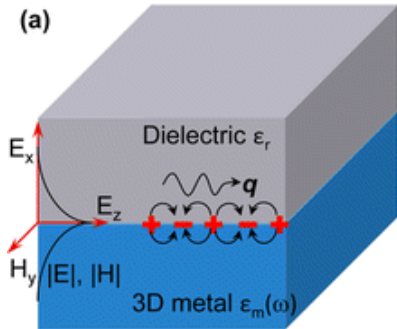
Intraband term
(Drude model)

Interband term
(not TD-friendly)



Random Phase Approximation (RPA)

Ellipsometric characterization? 2D? RPA model?



$$f(\omega) = \sinh(\omega/\omega_T) / [\cosh(\omega_F/\omega_T) + \cosh(\omega/\omega_T)] \quad \text{from Fermi-Dirac distribution}$$

ω frequency of incident light, [eV]

$\omega_T = k_B T$ temperature, converted to [eV]

ω_F chemical potential, [eV]

Γ, γ scattering rates, [eV]

\hbar the reduced Planck constant, [eV·s]

k_B the Boltzmann constant, [eV/K]

$\sigma_0 = \frac{e^2}{4\hbar}$ universal conductivity, [S]

e electron charge

INTRO: GRAPHENE MODELS

PhotonicVASEfit started as a Matlab script for ellipsometric characterization of graphene

- Modified Fresnel's formulas for arbitrary stacks with any number of 2D layers
- Levenberg-Marquardt algorithm, GUI in Matlab
- Models: RPA, Spline, Critical points (Padé approximation)

RPA

$$\sigma_{\text{RPA}}(\omega) = \frac{8\iota}{\pi} \frac{\omega_T}{\omega + \iota\Gamma} \log \left[2 \cosh \left(\frac{\omega_F}{2\omega_T} \right) \right] + \frac{4}{\iota\pi} (\omega + \iota\gamma) \int_0^{\infty} \frac{f(\omega')}{4\omega'^2 - (\omega + \iota\gamma)^2} d\omega'$$

Not TD friendly

Spline

```
% w - frequency range from ellipsometry
% w0 - spline points, fixed parameter
Sigma_spline = spline(w0, sigma_re_fit + sigma_im_fit, w)
```

Not TD friendly

Critical points model

$$\sigma(\omega) = \sigma_1 + \sum_{i \in I_1} \frac{a_{0,i}}{b_{0,i} - \iota\omega} + \sum_{i \in I_2} \frac{a_{0,i} - \iota\omega a_{1,i}}{b_{0,i} - \iota\omega b_{1,i} - \omega^2}$$

(Drude term) critical points term

FT

$$\sigma(t) = \sigma_1 \delta(t) + \sum_{i \in I_1} A_i e^{-\gamma_i t} U(t) + \sum_{i \in I_2} A_i e^{-\gamma_i t} \sin(\omega_i t - \varphi_i) U(t)$$

single pole damped oscillator, phase-relaxed

$$\mathbf{J}'_i + b_{0,i} \mathbf{J}_i = a_{0,i} \mathbf{E}$$

$$\mathbf{J}''_i + b_{1,i} \mathbf{J}'_i + b_{0,i} \mathbf{J}_i = \sigma_0 (a_{0,i} \mathbf{E} + a_{1,i} \mathbf{E}')$$

SBC

$$\begin{cases} \mathbf{J}_s = \sigma_0 \sigma_1 \mathbf{E}_x + \sum_i \mathbf{J}_i \\ \mathbf{n} \times (\mathbf{H}_1 - \mathbf{H}_2) = \mathbf{J}_s \end{cases}$$

TD friendly !

$$\sigma(\omega) \approx \frac{a_0 - \iota\omega a_1 + \dots + (-\iota\omega)^m a_m}{b_0 - \iota\omega b_1 + \dots + (-\iota\omega)^n}$$

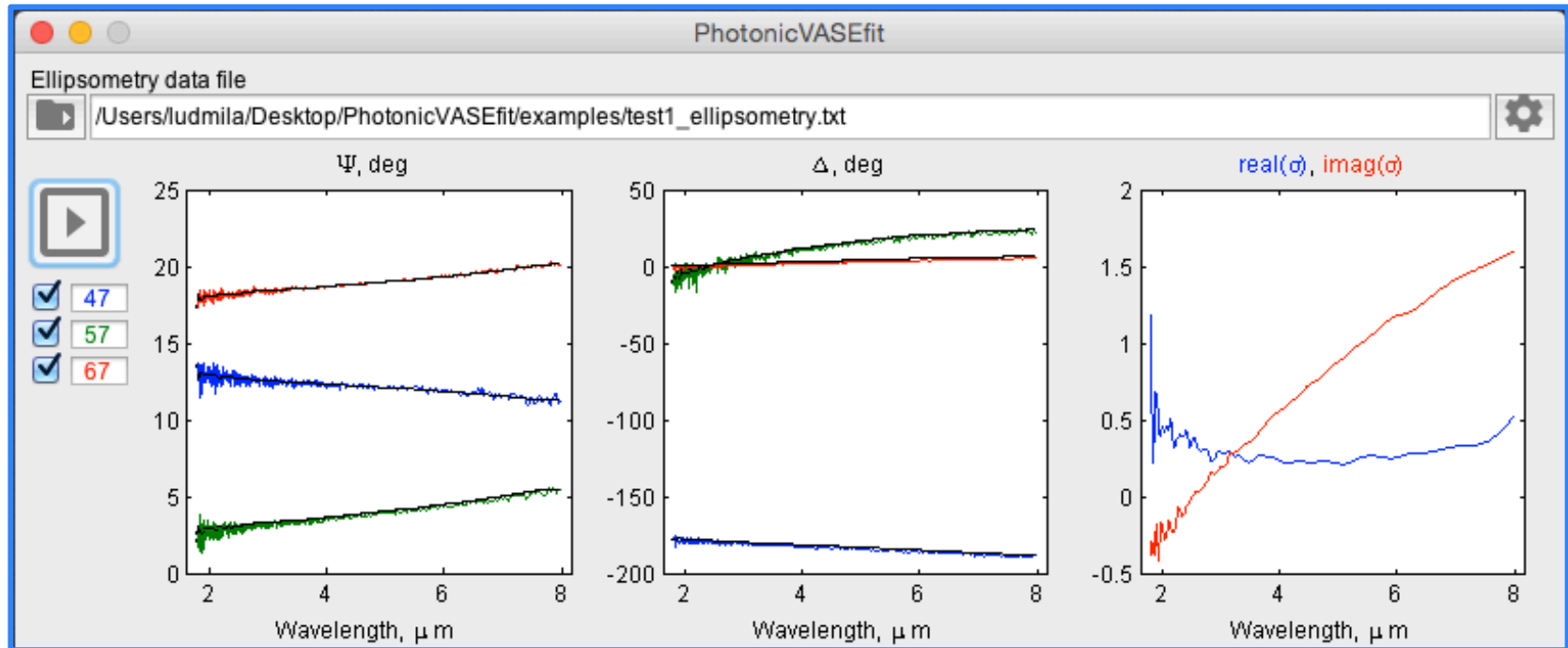
[m/n] Padé approximant, $m \leq n$

A_i amplitude
 ω_i oscillation frequency
 γ_i damping
 φ_i phase

$\delta(t)$ Dirac delta function
 $U(t)$ Heaviside step function

TUTORIAL

1. Data Selection (TUTORIAL)



- Accepted data file formats

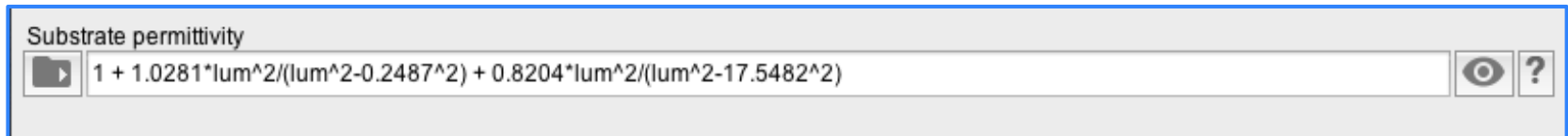
Wavelength	2*k columns k \geq 0	Ψ_1	Δ_1	2*m columns m \geq 0
duplicates are auto removed				



(Zero columns are auto removed)

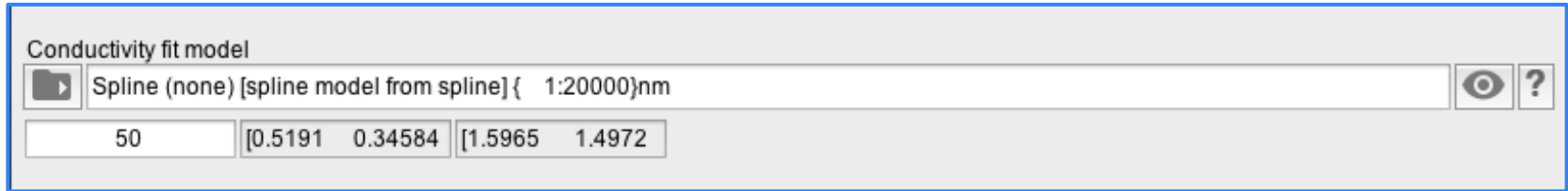
- Select ellipsometry data file
 - local files
 - remote files
- Auto scan (adjust if needed)
- Fit angles selectively (checkboxes)
- Filter Data
 - visual filter (brushing tool)
 - itemized filter

2. Substrate (TUTORIAL)



- Interactive multi-functional “Omnibox”:
 - “as-you-type” database search
 - formula input (from file or manual)
 - file import
- Table data AND models
- Quick look AND quick compare AND quick close
- Question mark

3. Conductivity Fitting Model (TUTORIAL)

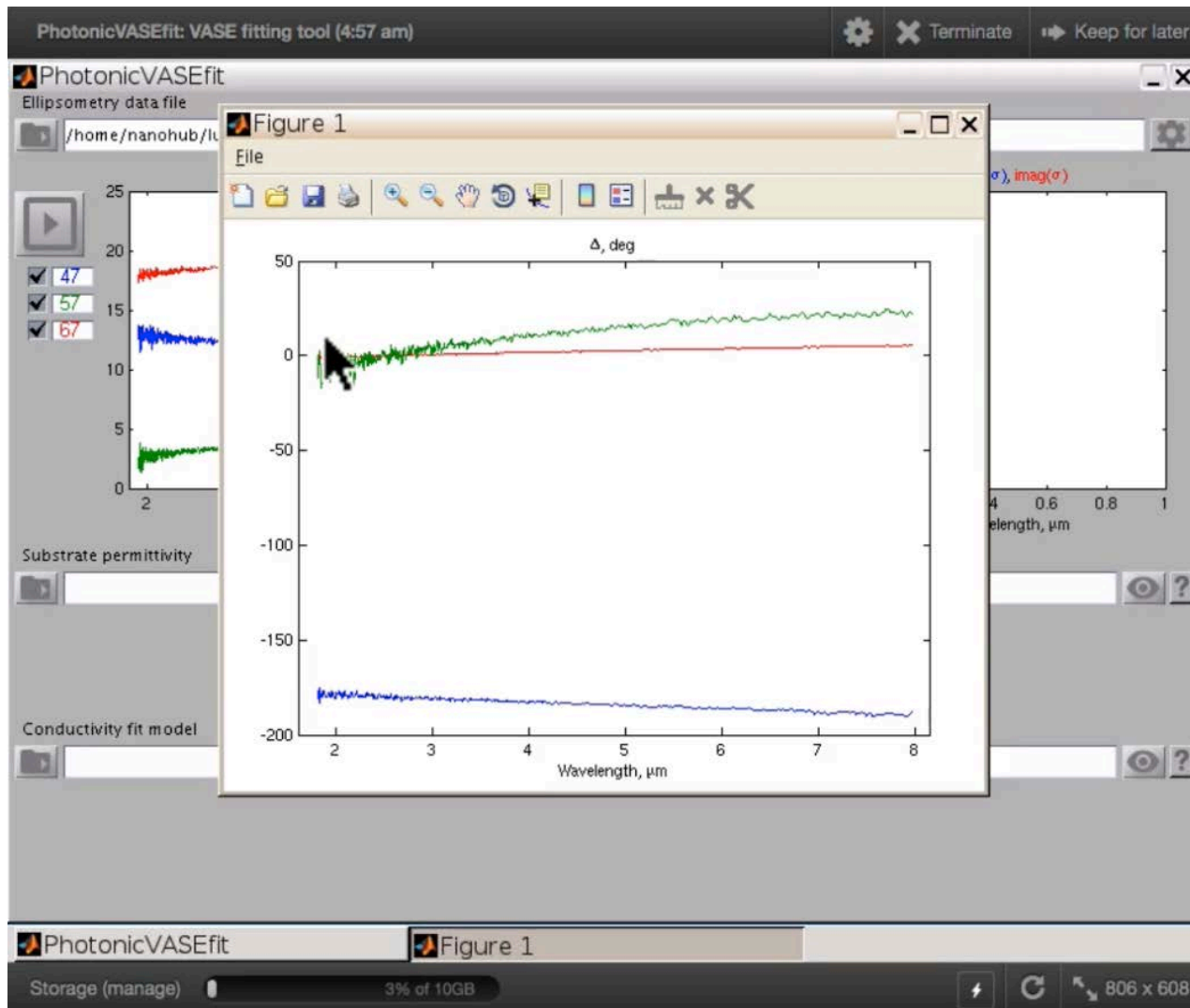


- Any model from database OR custom model
- Parameters are dynamically displayed
- Right click to include/exclude a parameter to fitting
 - white – fixed to current value
 - grayed – to be fitted using current value as initial value
- Results are not guaranteed
 - accurate substrate characterization
 - initial values
 - iteration limit

DEMO

<https://nanohub.org/resources/photoncvasefit>

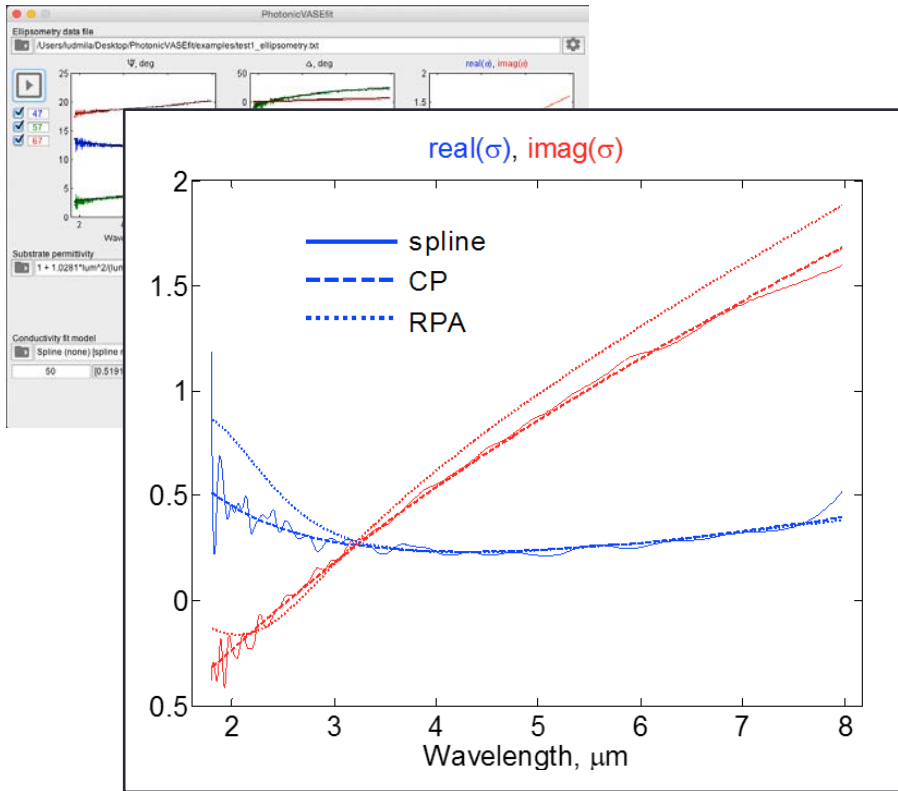
DEMO



USING RESULTS

RESULTS: Graphene

PhotonicVASEfit RESULTS for graphene



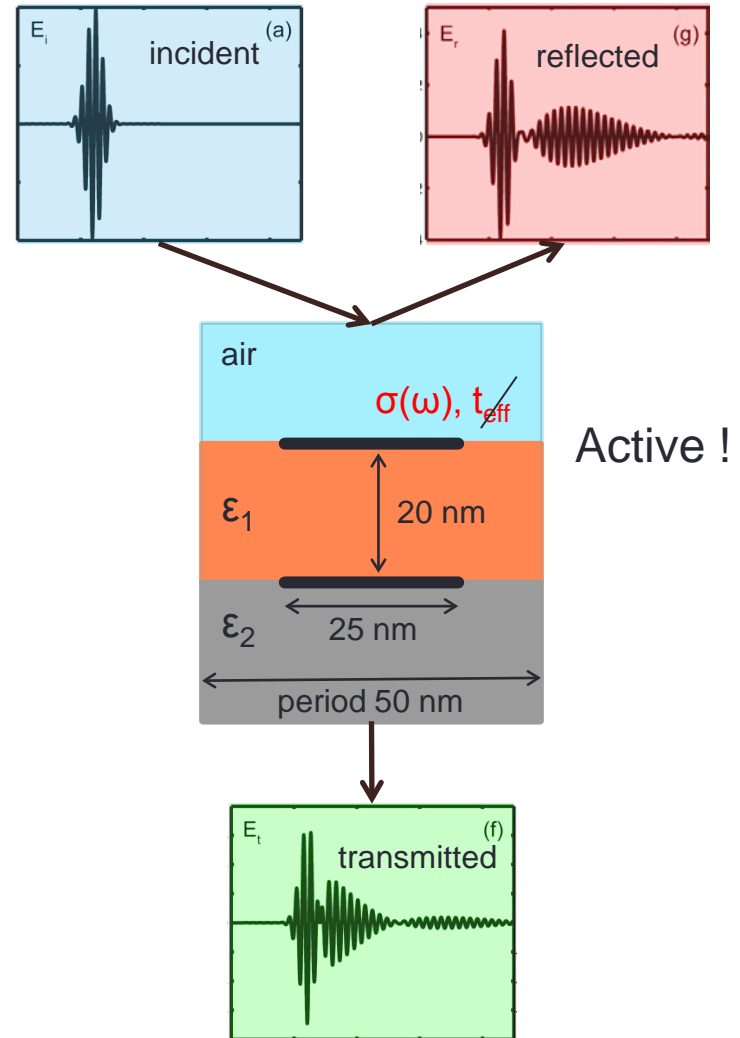
Spline – very good fit, slow (too many parameters ~100), does not represent physics, fictitious oscillations

RPA – physical parameters, T , E_F , γ retrieval, slow (iterative integration)

Critical points – good fit, only 4 parameters, causal (TD-friendly), fast

Critical points – good fit, only 4 parameters, causal (TD-friendly), fast

TD: Active Pulse Shaping with graphene nanoribbons

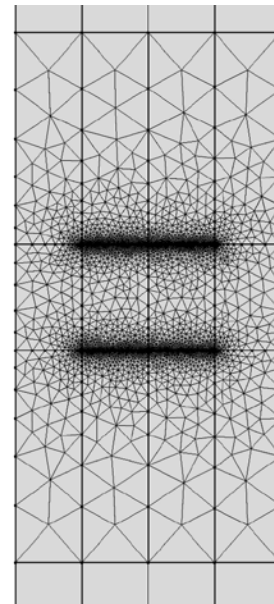
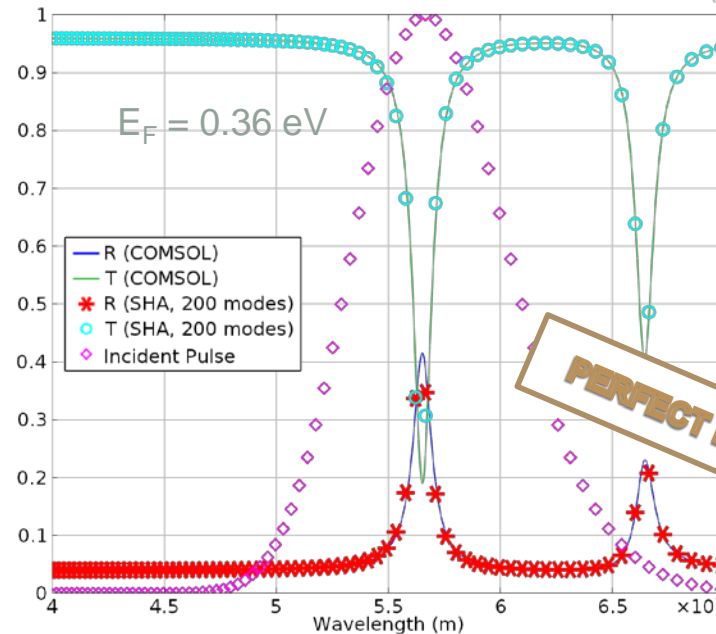
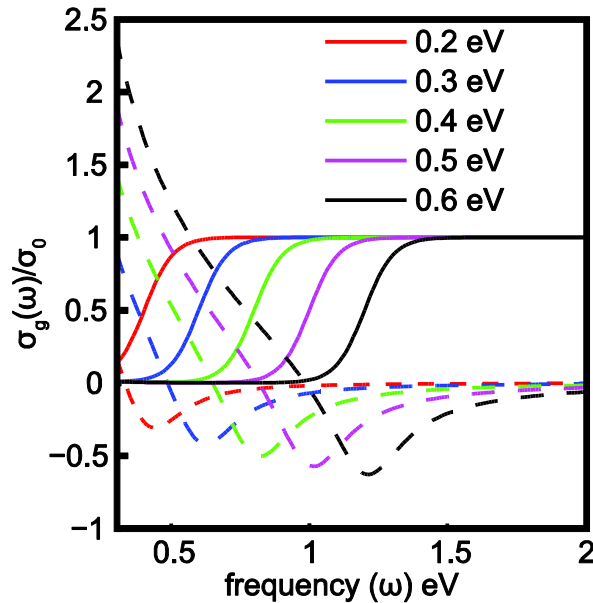
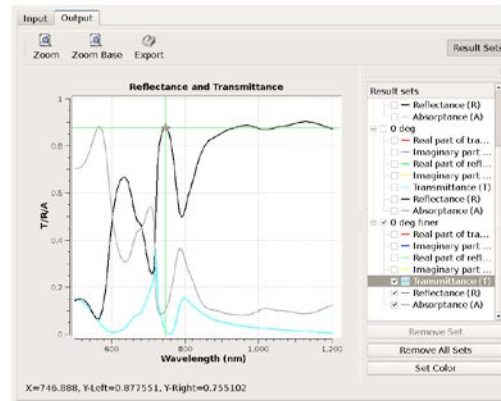
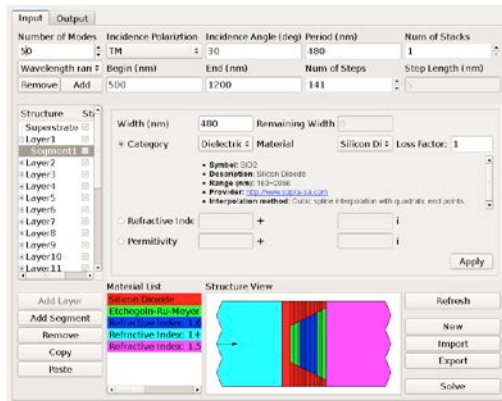


RESULTS: FD SIMULATIONS

EXPERIMENTALLY FITTED!



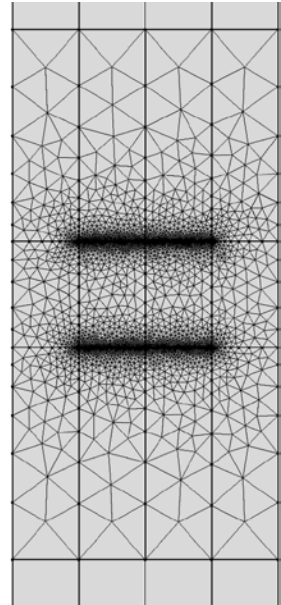
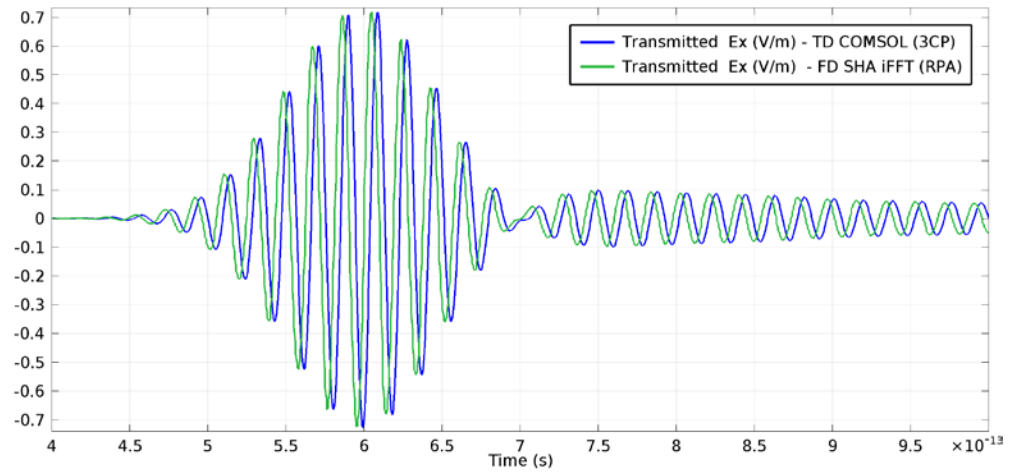
<https://nanohub.org/tools/sha2d>



RESULTS: TD SIMULATIONS

EXPERIMENTALLY FITTED!

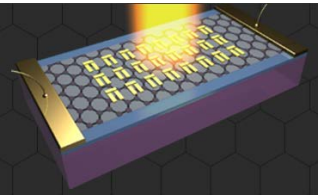
Good agreement between the TD (Comsol, 3CP) and FD iFFT (SHA, RPA) models



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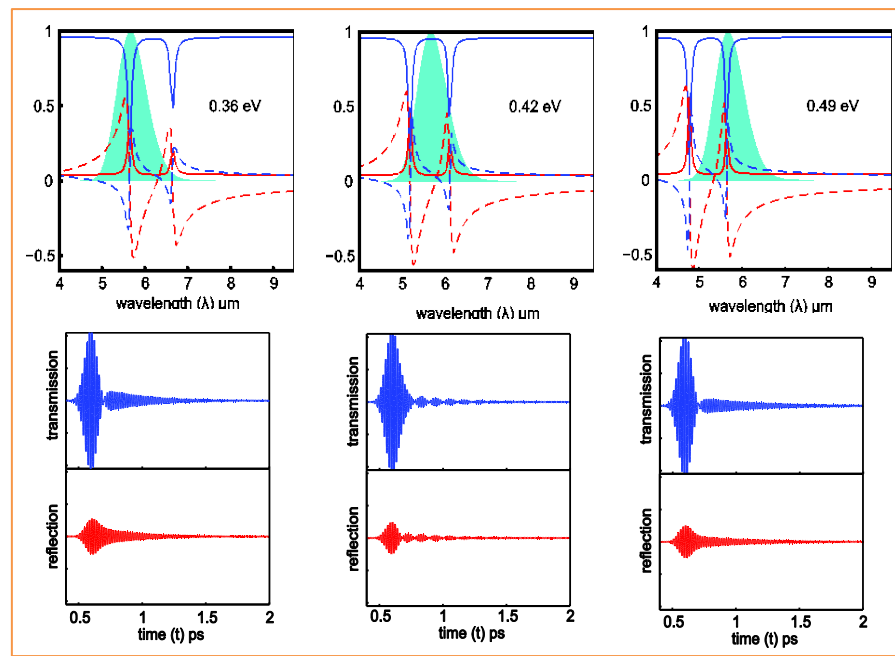


Simulating Graphene-Based Photonic and Optoelectronic Devices
Prof. A. V. Kildishev, Purdue University

Register at:
<http://www.comsol.com/events/webinars>

Models available at:
<http://www.comsol.com/community/exchange/361/>

FDTD with SBC
(unpublished)



THANK YOU!

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<https://nanohub.org/tools/photonicvasefit>

Cite this work

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[BibTex](#) [EndNote](#)